

FINAL



**Advanced
Micro
Devices**

Am27H256

256 Kilobit (32,768 x 8-Bit) High Speed CMOS EPROM

DISTINCTIVE CHARACTERISTICS

- **Fast access time**
 - 35 ns
- **JEDEC-approved pinout**
 - Pin compatible with Am27C256
- **Single +5 V power supply**
- **±10% power supply tolerance available**
- **100% Flashrite™ programming**
 - Typical programming time of 4 seconds
- **Latch-up protected to 100 mA from -1 V to Vcc + 1 V**
- **High noise immunity**
- **Standard 28-pin DIP, PDIP, 32-pin LCC and PLCC packages**
- **DESC SMD No. 5962-86063**

GENERAL DESCRIPTION

The Am27H256 is an 256 Kbit ultraviolet erasable programmable read-only memory. It is organized as 32K words by 8 bits per word, operates from a single +5 V supply, and features fast single address location programming. Products are available in windowed ceramic DIP and LCC packages as well as plastic one time programmable (OTP) PDIP and PLCC packages.

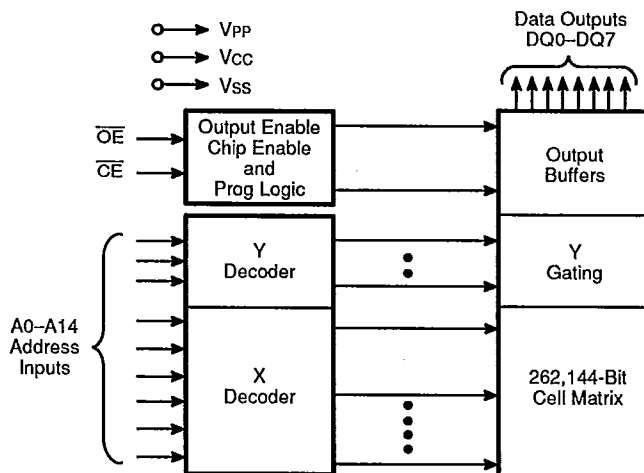
Typically, any byte can be accessed in less than 35 ns, allowing operation with high-performance microprocessors without any WAIT states. The Am27H256 offers separate Output Enable ($\overline{OE}$) and Chip Enable ($\overline{CE}$)

controls, thus eliminating bus contention in a multiple bus microprocessor system.

AMD's CMOS process technology provides high speed, low power, and high noise immunity. Typical power consumption is only 220 mW in active mode, and 50 mW in standby mode.

All signals are TTL levels, including programming signals. Bit locations may be programmed singly, in blocks, or at random. The Am27H256 supports AMD's Flashrite™ programming algorithm (100 μ s pulses) resulting in typical programming time of 4 seconds.

BLOCK DIAGRAM



14944C-1

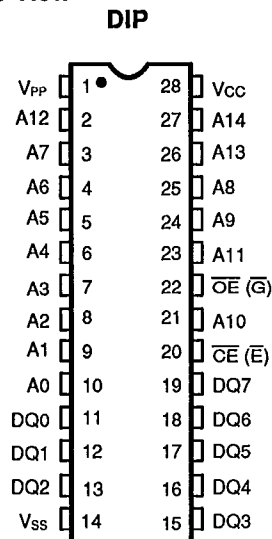


PRODUCT SELECTOR GUIDE

Family Part No.	Am27H256	
Ordering Part Number		
V _{CC} ± 5%	-35V05	
V _{CC} ± 10%	-35	-45
Max Access Time (ns)	35	-45
$\overline{CE}$ (E) Access Time (ns)	35	-45
$\overline{OE}$ (G) Access Time (ns)	20	20

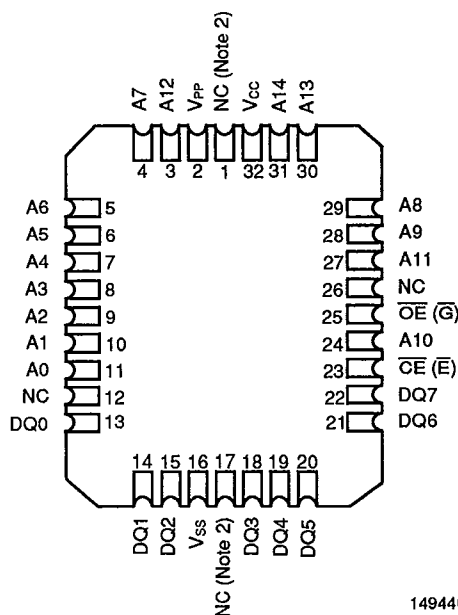
CONNECTION DIAGRAMS

Top View



14944C-2

PLCC/LCC



14944C-3

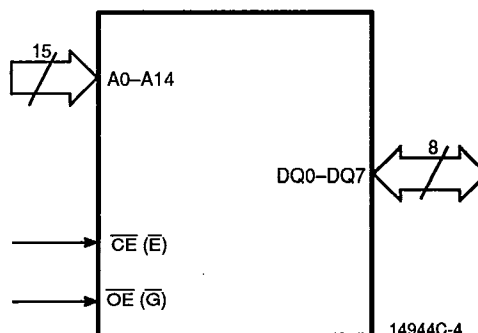
Notes:

1. JEDEC nomenclature is in parentheses.
2. Don't use (DU) for PLCC.

PIN DESIGNATIONS

A0–A14	=	Address Inputs
$\overline{CE}$ (E)	=	Chip Enable
DQ0–DQ7	=	Data Inputs/Outputs
NC	=	No Internal Connection
$\overline{OE}$ (G)	=	Output Enable Input
V _{CC}	=	V _{CC} Supply Voltage
V _{PP}	=	Program Supply Voltage
V _{SS}	=	Ground

LOGIC SYMBOL



14944C-4



ORDERING INFORMATION

EPROM Products

AMD Standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:

AM27H256

-35

D

C

B

OPTIONAL PROCESSING

Blank = Standard Processing
B = Burn-In

TEMPERATURE RANGE

C = Commercial (0°C to +70°C)
I = Industrial (-40°C to +85°C)
E = Extended Commercial (-55°C to +125°C)

PACKAGE TYPE

D = 28-Pin Ceramic DIP (CDV028)
L = 32-Pin Rectangular Ceramic Leadless Chip Carrier (CLV032)

SPEED OPTION

See Product Selector Guide and Valid Combinations

DEVICE NUMBER

Am27H256
256 Kilobit (32,768 x 8-Bit) CMOS EPROM

Valid Combinations	
AM27H256-35	DC, DCB, DI, DIB,
AM27H256-35V05	LC, LI, LCB, LIB
AM27H256-45	DC, DCB, DE, DEB,
	DI, DIB, LC, LCB,
	LI, LIB, LE, LEB

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.



ORDERING INFORMATION

OTP Products

AMD Standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:

AM27H256

-35

P

C

OPTIONAL PROCESSING

Blank = Standard Processing

TEMPERATURE RANGE

C = Commercial (0°C to +70°C)

PACKAGE TYPE

P = 28-Pin Plastic DIP (PD 032)

J = 32-Pin Rectangular Plastic Leaded Chip Carrier (PL 032)

SPEED OPTION

See Product Selector Guide and Valid Combinations

DEVICE NUMBER

Am27H256

256 Kilobit (32,768 x 8-Bit) CMOS OTP EPROM

Valid Combinations

Valid Combinations	
AM27H256-35V05	PC, JC
AM27H256-45	

Valid Combinations

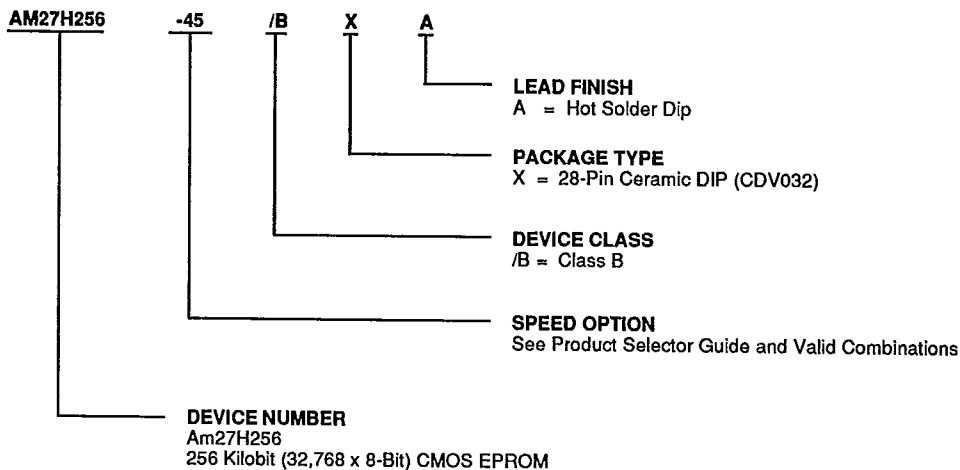
Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.



ORDERING INFORMATION

Military APL Products

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. APL (Approved Products List) products are fully compliant with MIL-STD-883 requirements. The order number (Valid Combination) is formed by a combination of:



Valid Combinations	
AM27H256-45	/BXA, /BUA

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

Group A Tests

Group A tests consist of Subgroups
1, 2, 3, 7, 8, 9, 10, 11.



FUNCTIONAL DESCRIPTION

Erasing the Am27H256

In order to clear all locations of their programmed contents, it is necessary to expose the Am27H256 to an ultraviolet light source. A dosage of 15 W seconds/cm² is required to completely erase an Am27H256. This dosage can be obtained by exposure to an ultraviolet lamp—wavelength of 2537 Å—with intensity of 12,000 μW/cm² for 15 to 20 minutes. The Am27H256 should be directly under and about one inch from the source and all filters should be removed from the UV light source prior to erasure.

It is important to note that the Am27H256 and similar devices will erase with light sources having wavelengths shorter than 4000 Å. Although erasure times will be much longer than with UV sources at 2537 Å, exposure to fluorescent light and sunlight will eventually erase the Am27H256 and exposure to them should be prevented to realize maximum system reliability. If used in such an environment, the package window should be covered by an opaque label or substance.

Programming the Am27H256

Upon delivery or after each erasure the Am27H256 has all 262,144 bits in the "ONE" or HIGH state. "ZEROS" are loaded into the Am27H256 through the procedure of programming.

The programming mode is entered when 12.75 V ± 0.25 V is applied to the V_{PP} pin, $\overline{CE}$ is at V_{IL} and $\overline{OE}$ is at V_{IH}.

For programming, the data to be programmed is applied 8 bits in parallel to the data output pins.

The Flashrite algorithm reduces programming time by using 100 μs programming pulses and by giving each address only as many pulses as is necessary in order to reliably program the data. After each pulse is applied to a given address, the data in that address is verified. If the data does not verify, additional pulses are given until it verifies or the maximum is reached. This process is repeated while sequencing through each address of the Am27H256. This part of the algorithm is done at V_{CC} = 6.25 V to assure that each EPROM bit is programmed to a sufficiently high threshold voltage. After the final address is completed, the entire EPROM memory is verified at V_{CC} = V_{PP} = 5.25 V.

Please refer to Section 6 for programming flow chart and characteristics.

Program Inhibit

Programming of multiple Am27H256 in parallel with different data is also easily accomplished. Except for $\overline{CE}$,

all like inputs of the parallel Am27H256 may be common. A TTL low-level program pulse applied to an Am27H256 $\overline{CE}$ input with V_{PP} = 12.75 V ± 0.25 V and $\overline{OE}$ high, will program that Am27H256. A high-level $\overline{CE}$ input inhibits the other Am27H256 devices from being programmed.

Program Verify

A verify should be performed on the programmed bits to determine that they were correctly programmed. The verify should be performed with $\overline{OE}$ at V_{IL}, $\overline{CE}$ at V_{IH} and V_{PP} between 12.5 V and 13.0 V.

Auto Select Mode

The auto select mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional in the 25°C ± 5°C ambient temperature range that is required when programming the Am27H256.

To activate this mode, the programming equipment must force 12.0 V ± 0.5 V on address line A9 of the Am27H256. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from V_{IL} to V_{IH}. All other address lines must be held at V_{IL} during auto select mode.

Byte 0 (A0 = V_{IL}) represents the manufacturer code, and byte 1 (A0 = V_{IH}), the device code. For the Am27H256, these two identifier bytes are given in the Mode Select Table. All identifiers for manufacturer and device codes will possess odd parity, with the MSB (DQ7) defined as the parity bit.

Read Mode

The Am27H256 has two control functions, both of which must be logically satisfied in order to obtain data at the outputs. Chip Enable ($\overline{CE}$) is the power control and should be used for device selection. Assuming that addresses are stable, address access time (t_{ACC}) is equal to the delay from $\overline{CE}$ to output (t_{CE}). Output Enable ($\overline{OE}$) is the output control and should be used to gate data to the output pins, independent of device selection. Data is available at the outputs t_{OE} after the falling edge of $\overline{OE}$, assuming that $\overline{CE}$ has been LOW and addresses have been stable for at least t_{ACC} - t_{OE}.



Standby Mode

The Am27H256 has a standby mode which reduces the maximum V_{CC} current to 50% of the active current. It is placed in standby mode when $\overline{CE}$ is at V_{IH} . The amount of current drawn in standby mode depends on the frequency and the number of address pins switching. The Am27H256 is specified with 50% of the address lines toggling at 10 MHz. A reduction of the frequency or quantity of address lines toggling will significantly reduce actual standby current.

Output OR-Tieing

To accommodate multiple memory connection, a two-line control function is provided to allow for:

- Low memory power dissipation
- Assurance that output bus contention will not occur

It is recommended that $\overline{CE}$ be decoded and used as the primary device-selecting function, while $\overline{OE}$ be made a common connection to all devices in the array and con-

nected to the READ line from the system control bus. This assures that all deselected memory devices are in low-power standby mode and that the output pins are only active when data is desired from a particular memory device.

System Applications

During the switch between active and standby conditions, transient current peaks are produced on the rising and falling edges of Chip Enable. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. At a minimum, a 0.1- μ F ceramic capacitor (high frequency, low inherent inductance) should be used on each device between V_{CC} and V_{SS} to minimize transient effects. In addition, to overcome the voltage drop caused by the inductive effects of the printed circuit board traces on EPROM arrays, a 4.7- μ F bulk electrolytic capacitor should be used between V_{CC} and V_{SS} for each eight devices. The location of the capacitor should be close to where the power supply is connected to the array.

MODE SELECT TABLE

Mode		Pins	$\overline{CE}$	$\overline{OE}$	A0	A9	V_{PP}	Outputs
Read			V_{IL}	V_{IL}	A0	A9	V_{CC}	DOUT
Output Disable			V_{IL}	V_{IH}	X	X	V_{CC}	Hi-Z
Standby			V_{IH}	X	X	X	V_{CC}	Hi-Z
Program			V_{IL}	V_{IH}	X	X	V_{PP}	DIN
Program Verify			V_{IH}	V_{IL}	X	X	V_{PP}	DOUT
Program Inhibit			V_{IH}	V_{IH}	X	X	V_{PP}	Hi-Z
Auto Select (Note 3)	Manufacturer Code		V_{IL}	V_{IL}	V_{IL}	V_{H}	V_{CC}	01H
	Device Code		V_{IL}	V_{IL}	V_{IH}	V_{H}	V_{CC}	10H

Notes:

1. $V_H = 12.0 V \pm 0.5 V$
2. X = Either V_{IH} or V_{IL}
3. A1-A8 = A10-A14 = V_{IL}
4. The Am27H256 uses the same Flashrite algorithm during programming as the Am27C256.



ABSOLUTE MAXIMUM RATINGS

Storage Temperature	
OTP Products	−65°C to +125°C
All Other Products	−65°C to +150°C
Ambient Temperature	
with Power Applied	−55°C to +125°C
Voltage with Respect to V_{SS}	
All pins except A9, V_{PP} , V_{CC}	−0.6 V to $V_{CC} + 0.5$ V
(Note 1)	
A9 and V_{PP} (Note 2)	−0.6 V to +13.5 V
V_{CC}	−0.6 V to +7.0 V

Notes:

1. Minimum DC voltage on input or I/O pins is −0.5 V. During transitions, the inputs may overshoot V_{SS} to −2.0 V for periods of up to 20 ns. Maximum DC voltage on input and I/O pins is $V_{CC} + 0.5$ V which may overshoot to $V_{CC} + 2.0$ V for periods up to 20 ns.
2. For A9 and V_{PP} the minimum DC input is −0.5 V. During transitions, A9 and V_{PP} may overshoot V_{SS} to −2.0 V for periods of up to 20 ns. A9 and V_{PP} must not exceed 13.5 V for any period of time.

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Case Temperature (T_C)	0°C to +70°C
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Industrial (I) Devices

Case Temperature (T_C)	−40°C to +85°C
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Extended Commercial (E) Devices

Case Temperature (T_C)	−55°C to +125°C
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Military (M) Devices

Case Temperature (T_C)	−55°C to +125°C
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Supply Read Voltages

V_{CC} for Am27H256-XXV05	+4.75 V to +5.25 V
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V_{CC} for Am27H256-XX0	+4.50 V to +5.50 V
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Operating ranges define those limits between which the functionality of the device is guaranteed.



DC CHARACTERISTICS over operating range unless otherwise specified.

(Notes 1, 2, 3 and 4) (for APL Products, Group A, Subgroups 1, 2, 3, 7 and 8 are tested unless otherwise noted)

Parameter Symbol	Parameter Description	Test Conditions	Min	Max	Unit
V _{OH}	Output HIGH Voltage	I _{OH} = -4 mA	2.4		V
V _{OL}	Output LOW Voltage	I _{OL} = 12 mA		0.45	V
V _{IH}	Input HIGH Voltage		2.0	V _{CC} + 0.5	V
V _{IL}	Input LOW Voltage		-0.3	+0.8	V
I _{LI}	Input Load Current	V _{IN} = 0 V to +V _{CC}	C/I Devices	1.0	μA
			E/M Devices	1.0	
I _{LO}	Output Leakage Current	V _{OUT} = 0 V to +V _{CC}	C/I Devices	10.0	μA
			E/M Devices	10.0	
I _{CC1}	V _{CC} Active Current (Note 3)	$\overline{OE} = V_{IL}$, f = 10 MHz I _{OUT} = 0 mA	C/I Devices	50	mA
			E/M Devices	60	
I _{CC2}	V _{CC} Standby Current	$\overline{OE} = V_{IH}$	C/I Devices	25	mA
			E/M Devices	35	
I _{PP1}	V _{PP} Current During Read	$\overline{OE} = \overline{OE} = V_{IL}$, V _{PP} = V _{CC}		100	μA

Notes:

1. V_{CC} must be applied simultaneously or before V_{PP}, and removed simultaneously or after V_{PP}.
2. **Caution:** The Am27H256 must not be removed from (or inserted into) a socket when V_{CC} or V_{PP} is applied.
3. I_{CC1} is tested with $\overline{OE}/V_{PP} = V_{IH}$ to simulate open outputs.
4. Minimum DC Input Voltage is -0.5 V. During transitions, the inputs may overshoot to -2.0 V for periods less than 20 ns. Maximum DC Voltage on output pins is V_{CC} + 0.5 V, which may overshoot to V_{CC} + 2.0 V for periods less than 20 ns.

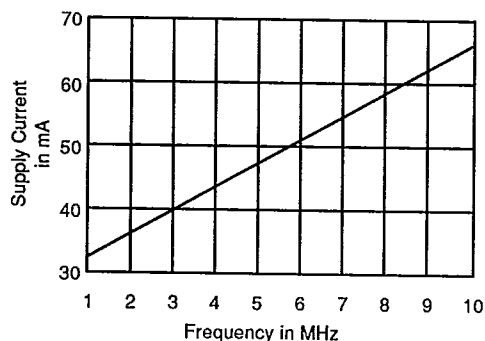


Figure 1. Typical Supply Current
vs. Frequency
V_{CC} = 5.0 V, T = 25°C

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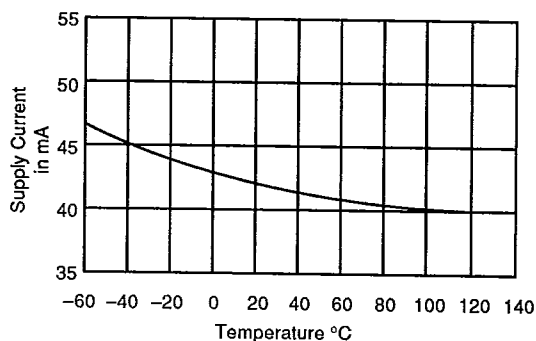


Figure 2. Typical Supply Current
vs. Temperature
V_{CC} = 5.0 V, f = 10 MHz

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CAPACITANCE

Parameter Symbol	Parameter Description	Test Conditions	CDV028		CLV032		PD 028		PL 032		Unit
			Typ	Max	Typ	Max	Typ	Max	Typ	Max	
CIN	Input Capacitance	VIN = 0	6	12	6	12	8	12	8	12	pF
COUT	Output Capacitance	VOUT = 0	8	15	6	15	10	15	10	15	pF

Notes:

1. This parameter is only sampled and not 100% tested.
2. $T_A = +25^\circ\text{C}$, $f = 1\text{ MHz}$.

SWITCHING CHARACTERISTICS over operating range unless otherwise specified
(Notes 1, 3 and 4) (for APL Products, Group A, Subgroups 9,10 and 11 are tested unless otherwise noted)

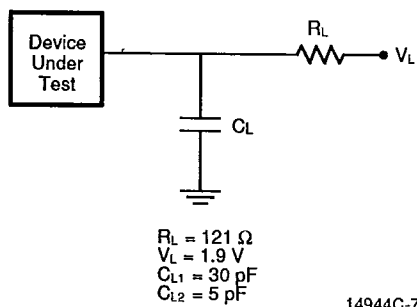
Parameter Symbols		Parameter Description	Test Conditions	Am27H256	
				-35V05 -35	-45
tAVQV	tRCC	Address to Output Delay	$\overline{\text{OE}} = \overline{\text{OE}} = V_{IL}$ $C_L = C_{L1}$	Min	
				Max	35
tELQV	tCE	Chip Enable to Output Delay	$\overline{\text{OE}} = V_{IL}$ $C_L = C_{L1}$	Min	
				Max	35
tGLQV	tOE	Output Enable to Output Delay	$\overline{\text{OE}} = V_{IL}$ $C_L = C_{L1}$	Min	
				Max	20
tEHQZ, tGHQZ	tDF (Note 2)	Chip Enable HIGH or Output Enable HIGH, whichever comes first, to Output Float	$C_L = C_{L2}$	Min	0
				Max	20
tAXQX	tOH	Output Hold from Addresses, $\overline{\text{OE}}$, or $\overline{\text{OE}}$, whichever occurred first		Min	0
				Max	

Notes:

1. Vcc must be applied simultaneously or before Vpp, and removed simultaneously or after Vpp.
2. This parameter is only sampled and not 100% tested.
3. **Caution:** The Am27H256 must not be removed from (or inserted into) a socket or board when Vpp or Vcc is applied.
4. Output Load: 1 TTL gate and $C = C_L$
Input Rise and Fall Times: 5 ns
Input Pulse Levels: 0 V to 3 V.
Timing Measurement Reference Level: 1.5 V for inputs and outputs

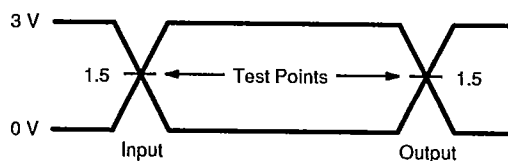


SWITCHING TEST CIRCUIT



14944C-7

SWITCHING TEST WAVEFORM



14944C-8

AC Testing: Inputs are driven at 3.0 V for a logic "1" and 0 V for a logic "0." Input pulse rise and fall times are $\leq 5 \text{ ns}$.

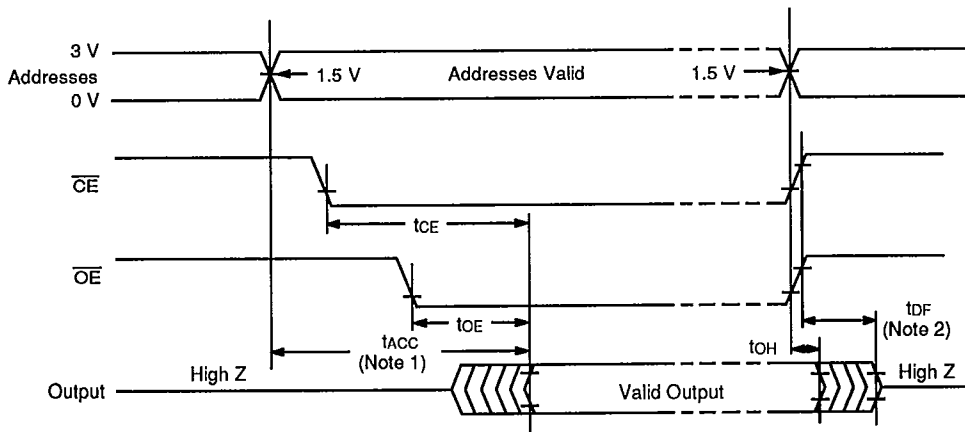


KEY TO SWITCHING WAVEFORMS

WAVEFORM	INPUTS	OUTPUTS
	Must Be Steady	Will Be Steady
	May Change from H to L	Will Be Changing from H to L
	May Change from L to H	Will Be Changing from L to H
	Don't Care, Any Change Permitted	Changing State Unknown
	Does Not Apply	Center Line is High Impedance "Off" State

KS000010

SWITCHING WAVEFORMS



14944C-9

Notes:

- $\overline{OE}$ may be delayed up to $t_{ACC} - t_{OE}$ after the falling edge of the addresses without impact on t_{ACC} .
- t_{DF} is specified from $\overline{OE}$ or $\overline{CE}$, whichever occurs first.